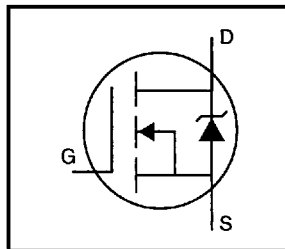


HEXFET® Power MOSFET

- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DS} = 250V$$

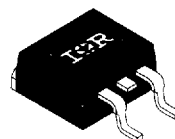
$$R_{DS(on)} = 1.1\Omega$$

$$I_D = 4.4A$$

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



SMD-220

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	4.4	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	2.8	
I_{DM}	Pulsed Drain Current ①	14	
$P_D @ T_C = 25^\circ C$	Power Dissipation	50	W
$P_D @ T_A = 25^\circ C$	Power Dissipation (PCB Mount)**	3.1	
	Linear Derating Factor	0.40	
	Linear Derating Factor (PCB Mount)**	0.025	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	
E_{AS}	Single Pulse Avalanche Energy ②	100	mJ
I_{AR}	Avalanche Current ①	4.4	A
E_{AR}	Repetitive Avalanche Energy ①	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.8	V/ns
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to +150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

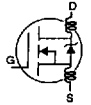
	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	—	2.5	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)**	—	—	40	
$R_{\theta JA}$	Junction-to-Ambient	—	—	62	

** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	250	—	—	V	$V_{GS}=0V$, $I_D=250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.36	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D=1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	1.1	Ω	$V_{GS}=10V$, $I_D=2.6A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}$, $I_D=250\mu A$
g_{fs}	Forward Transconductance	1.5	—	—	S	$V_{DS}=50V$, $I_D=2.6A$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS}=250V$, $V_{GS}=0V$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{DS}=200V$, $V_{GS}=0V$, $T_J=125^\circ\text{C}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS}=-20V$
Q_g	Total Gate Charge	—	—	14	nC	$I_D=4.4A$
Q_{gs}	Gate-to-Source Charge	—	—	2.7		$V_{DS}=200V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	7.8		$V_{GS}=10V$ See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	7.0	—	ns	$V_{DD}=125V$
t_r	Rise Time	—	13	—		$I_D=4.4A$
$t_{d(off)}$	Turn-Off Delay Time	—	20	—		$R_G=18\Omega$
t_f	Fall Time	—	12	—		$R_D=28\Omega$ See Figure 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	260	—	pF	$V_{GS}=0V$
C_{oss}	Output Capacitance	—	77	—		$V_{DS}=25V$
C_{rss}	Reverse Transfer Capacitance	—	15	—		$f=1.0MHz$ See Figure 5



Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	4.4	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	14		
V_{SD}	Diode Forward Voltage	—	—	1.8	V	$T_J=25^\circ\text{C}$, $I_S=4.4A$, $V_{GS}=0V$ ④
t_{rr}	Reverse Recovery Time	—	200	400	ns	$T_J=25^\circ\text{C}$, $I_F=4.4A$
Q_{rr}	Reverse Recovery Charge	—	0.93	1.9	μC	$di/dt=100A/\mu s$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

③ $I_{SD} \leq 4.4A$, $di/dt \leq 90A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 150^\circ\text{C}$

② $V_{DD}=50V$, starting $T_J=25^\circ\text{C}$, $L=8.3mH$, $R_G=25\Omega$, $I_{AS}=4.4A$ (See Figure 12)

④ Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

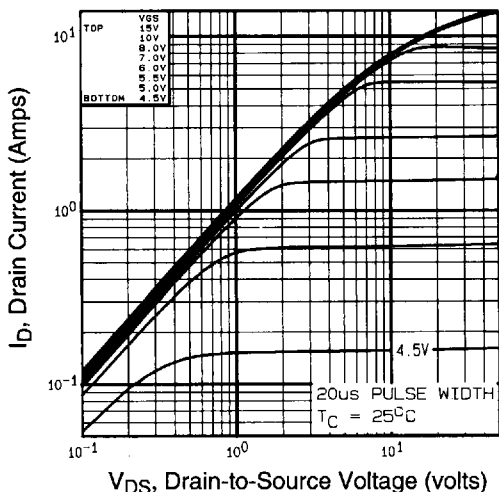


Fig 1. Typical Output Characteristics,
 $T_C=25^\circ\text{C}$

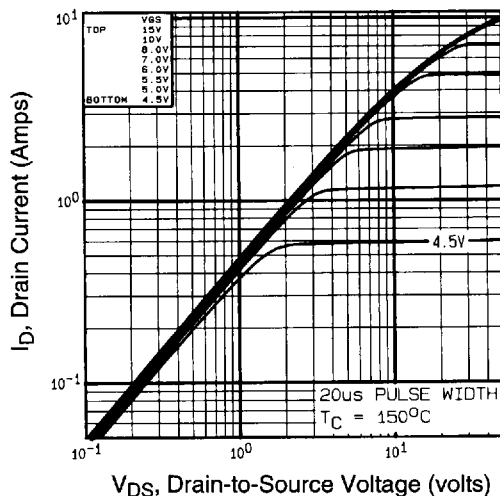


Fig 2. Typical Output Characteristics,
 $T_C=150^\circ\text{C}$

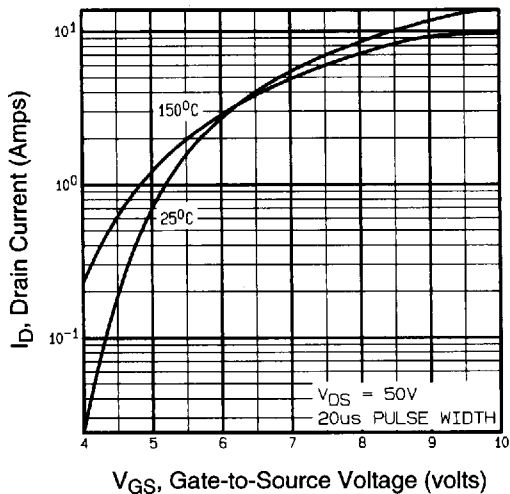


Fig 3. Typical Transfer Characteristics

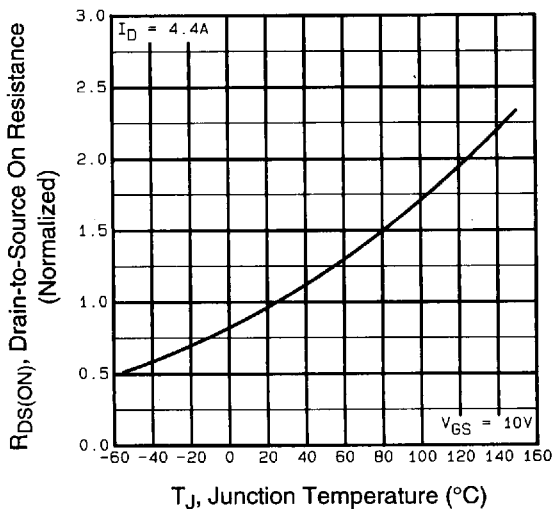


Fig 4. Normalized On-Resistance
Vs. Temperature

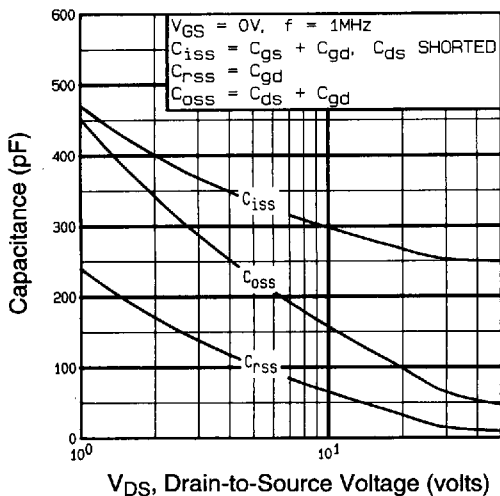


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

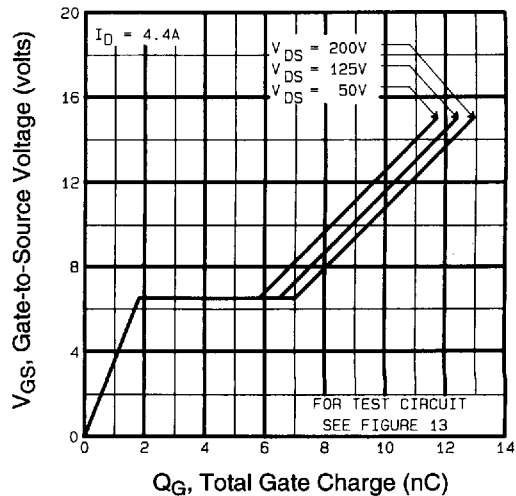


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

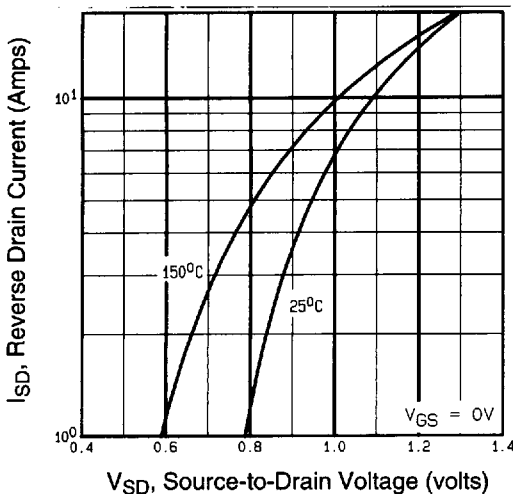


Fig 7. Typical Source-Drain Diode Forward Voltage

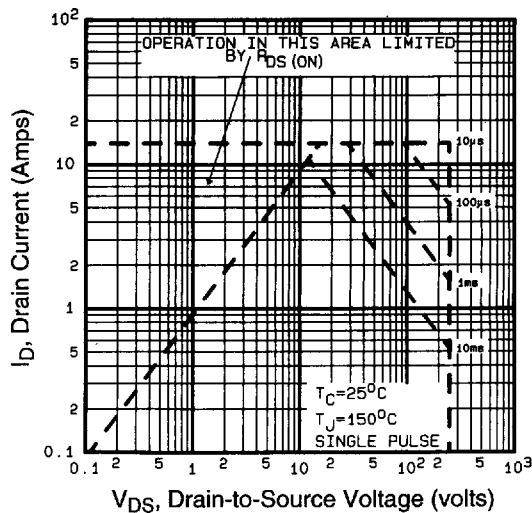


Fig 8. Maximum Safe Operating Area

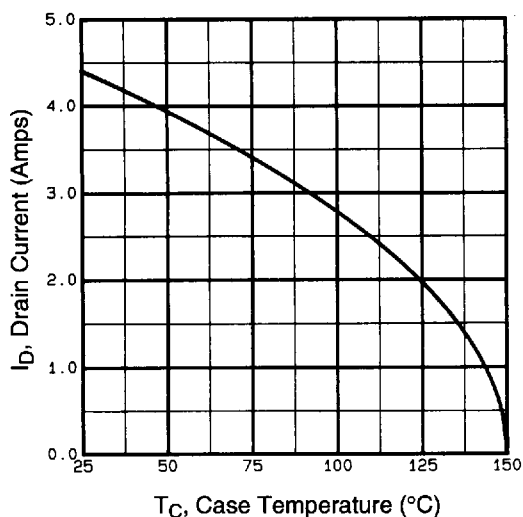


Fig 9. Maximum Drain Current Vs. Case Temperature

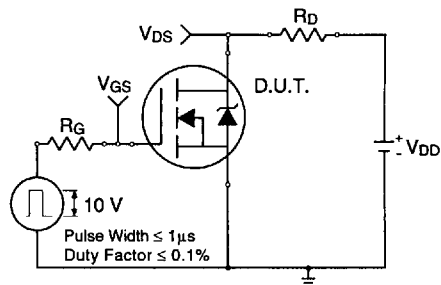


Fig 10a. Switching Time Test Circuit

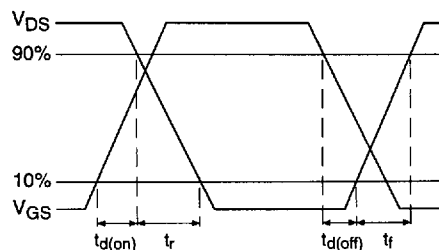


Fig 10b. Switching Time Waveforms

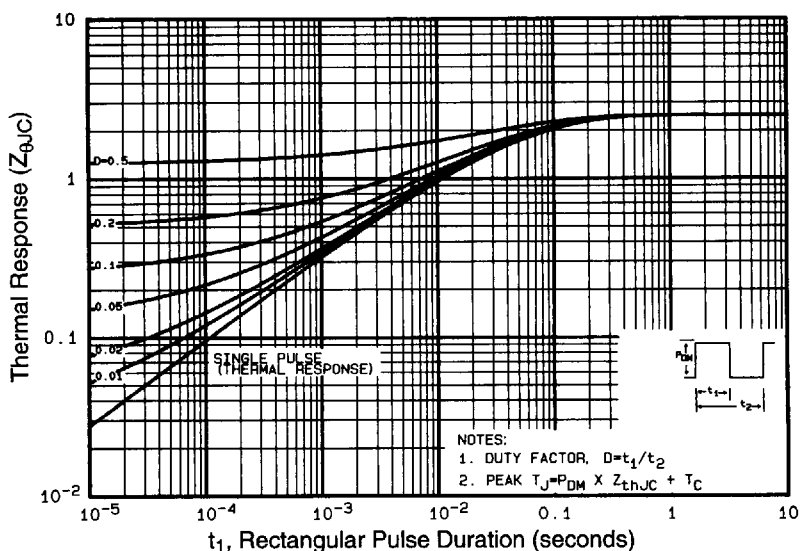


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

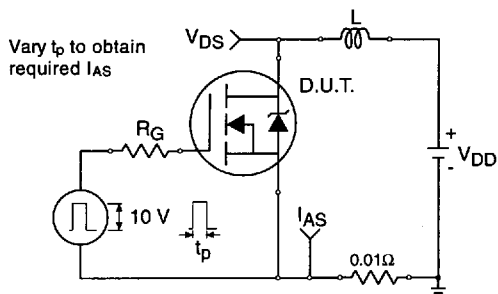


Fig 12a. Unclamped Inductive Test Circuit

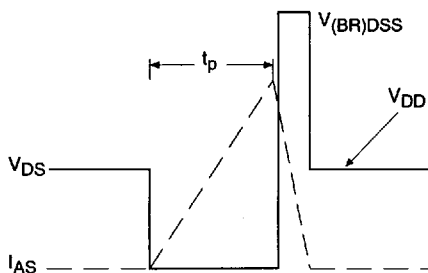


Fig 12b. Unclamped Inductive Waveforms

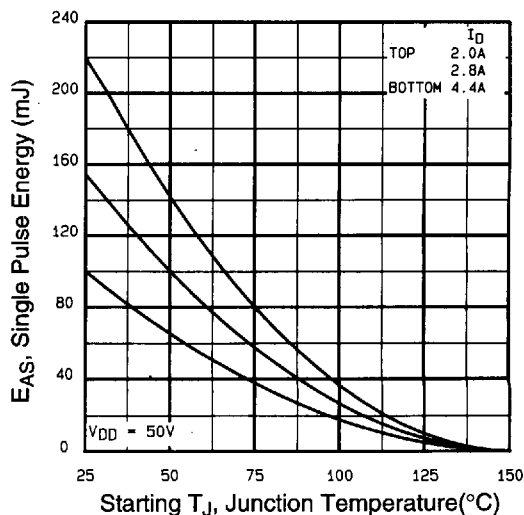


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

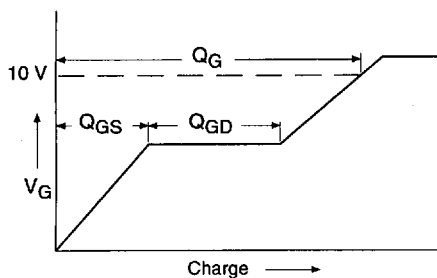


Fig 13a. Basic Gate Charge Waveform

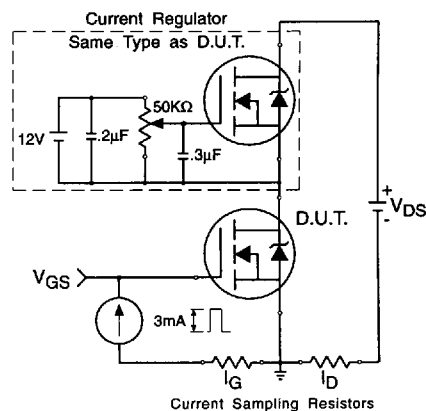


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit

Appendix B: Package Outline Mechanical Drawing

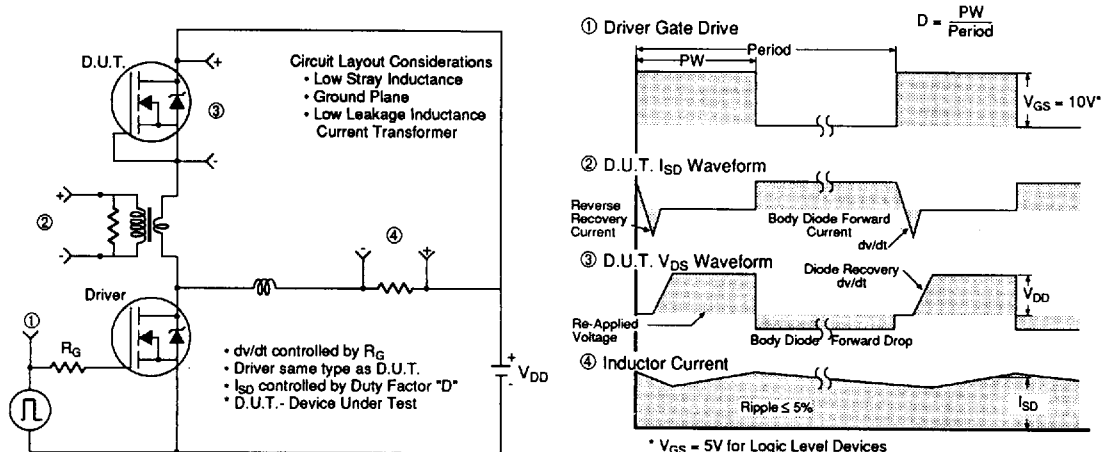
Appendix C: Part Marking Information

Appendix D: Tape & Reel Information

Appendix A

Peak Diode Recovery dv/dt Test Circuit

Fig 14. For N-Channel HEXFETs

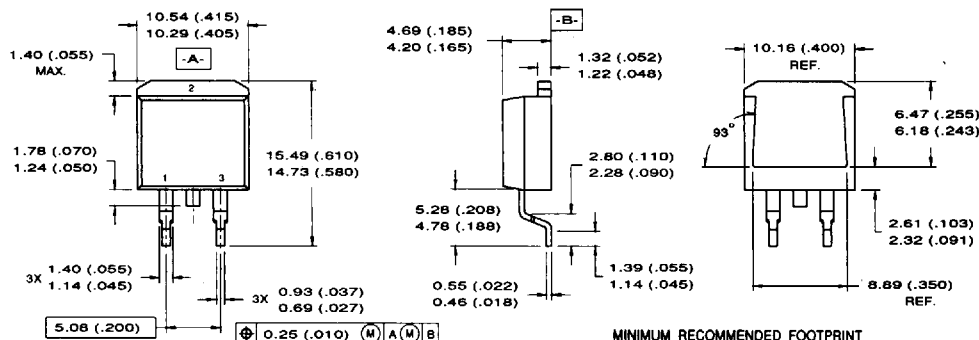


Appendix B

Package Outline

SMD-220 Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1 DIMENSIONS AFTER SOLDER DIP.
- 2 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982
- 3 CONTROLLING DIMENSION: INCH.
- 4 HEATSINK & LEAD DIMENSIONS DO NOT INCLUDE BURRS.

LEAD ASSIGNMENTS

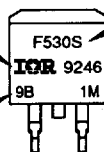
- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE

Part Marking Information

SMD-220

EXAMPLE: THIS IS AN IRF530S WITH
ASSEMBLY LOT CODE 9B1M

INTERNATIONAL
RECTIFIER
LOGO
ASSEMBLY
LOT CODE

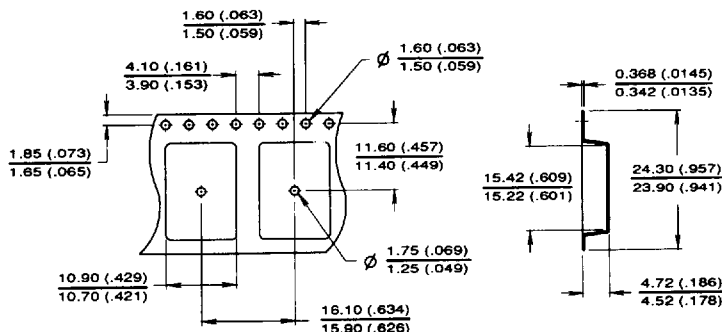
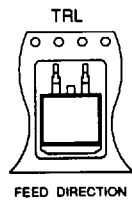
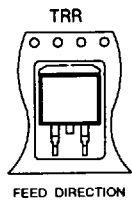


PART NUMBER

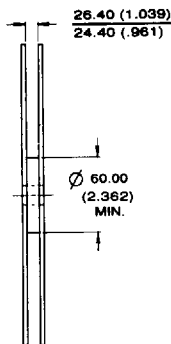
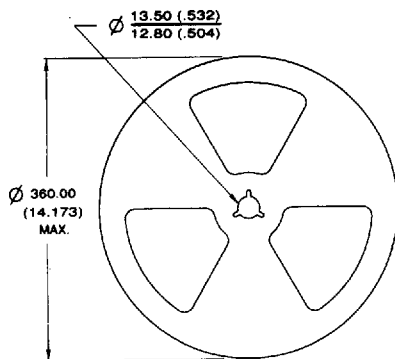
DATE CODE
(YYWW)
YY = YEAR
WW = WEEK

Tape & Reel Information

SMD-220 Tape & Reel



ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES)



SMD-220 Tape & Reel

When ordering, indicate the part number, part orientation, and the quantity. Quantities are in multiples of 800 pieces per reel for both TRL and TRR.



Printed on Signet recycled offset:
made from 50% recycled waste paper, including
10% de-inked, post-consumer waste.



International
IRF Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322-3331, Twx: 4720403
EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB England, Tel: (0883) 713215, Twx: 95219

IR CANADA: 101 Bentley St., Markham, Ontario L3R 3L1, Tel: (416) 475-1897. IR GERMANY: Saalburgstrasse 157, D-6380 Bad Homburg, Tel: 6172-37066. IR ITALY: Via Liguria 49 10071 Borgaro, Torino, Tel: (011) 470 1484. IR FAR EAST: K&H Building, 30-4 Nishitakebukuro 3-Chome, Toshima-ku, Tokyo 171 Japan, Tel: (03) 983 0641. IR SOUTHEAST ASIA: 190 Middle Road, HEX 10-01 Fortune Centre, Singapore 0718, Tel: (65) 336 3922.

4855452 0021467 205

Printed in U.S.A. 2/94 5m

Sales Offices, Agents and Distributors in Major Cities Throughout the World.

44552

Data and specifications subject to change without notice. (1092)